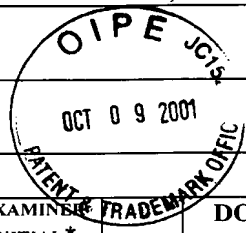

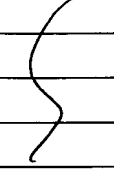






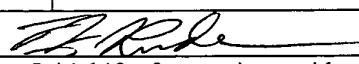


Form PTO 1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT <i>(Use Several Sheets if Necessary)</i>		Attorney Docket No. 8733.464.00		Application No. 09/901,079		
Date: October 10, 2001		Applicant Dong Hoon LEE et al.				
		Filing Date July 10, 2001		Group 2871		
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EXAMINER 			DATE CONSIDERED 5/27/03			
*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						
**English-language abstract provided.						